

Notice of References Cited	Application/Control No. 10/796,251	Applicant(s)/Patent Under Reexamination ITOH ET AL.	
	Examiner Yoon-Young Kim	Art Unit 1723	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,506,389	04-1996	Hidano et al.	219/390
*	B	US-4,871,456	10-1989	Naruo et al.	210/321.84
*	C	US-2003/0159981 A1	08-2003	Diemer et al.	210/346
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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